10113B, F: -30 to +85°C, CERDIP

DIGITAL 10,000 SERIES ECL

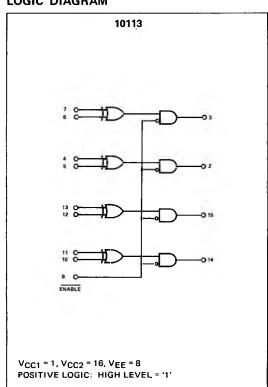
DESCRIPTION

The 10113 is a four gate array designed to provide the positive logic Exclusive OR function in high performance applications. This device contains a temperature compensated internal bias which insures that the threshold point remains in the center of the transition region over temperature. Input pulldown resistors eliminate the need to tie unused inputs to VEE.

Open emitter outputs are provided to enable bussing of multiple outputs together. If the four outputs of the 10113 are wire-ORed together the device performs a 4-bit compare function (outputs low for compare).

The outputs are all gated by the enable input. If this enable input is high all outputs will be forced low.

LOGIC DIAGRAM



FEATURES

- PERFORMS 4-BIT COMPARE FUNCTION (IF OUT-PUTS ARE WIRE- ORed TOGETHER)
- HIGH FUNCTIONAL DENSITY FOUR EXCLU-SIVE OR GATES/PACKAGE
- FAST PROPAGATION DELAY FOR EXCLUSIVE OR: 2.5 ns TYP
- LOW POWER DISSIPATION: 165 mW/PACKAGE TYP (NO LOAD)
- HIGH FANOUT CAPABILITY CAN DRIVE FOUR 50 Ω LINES
- HIGH Z INPUTS INTERNAL 50 kΩ PULLDOWNS
- HIGH IMMUNITY FROM POWER SUPPLY VARIA-TIONS: VEE = -5.2 V ±5% RECOMMENDED
- OPEN EMITTER LOGIC AND BUSSING CAPABILITY
- OUTPUT ENABLE GATING MAKES POWERFUL LOGIC FUNCTION

APPLICATIONS

- QUAD EXCLUSIVE-OR (For parity, error correcting, and other logic functions).
- FOUR-BIT COMPARATOR (For logic, test equipment, error detection applications).
- GATED FOUR-BIT COMPARATOR (Enable input permits wire-ORing multiples of four bits)

TRUTH TABLE

E9	IN 7	IN 6	OUT 3
L	L	L	L
L	L	н	н
L	н	L	н
L	н	н	L
н	φ	φ	L

 ϕ = Don't Care.

TEMPERATURE RANGE

-30 to +85°C Operating Ambient

PACKAGE TYPES

- B: 16-Pin Silicone DIP
- F: 16-Pin CERDIP

ELECTRICAL CHARACTERISTICS

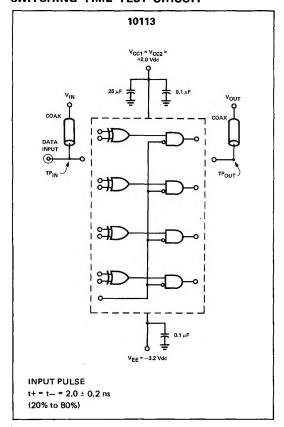
(at Listed Voltages and Ambient Temperatures).

	TEST VOLTAGE VALUES												
@ Test		(Volte)											
Temperature	VIH max	VIL min	VIHA min	VILA max	VEE								
-30°C	-0.890	-1.890	-1.205	-1.500	-5.2								
+25^C	-0.810	-:1.850	1.106	-1.475	-5.2								
+86°C	-0.700	-1.825	-1.035	-1.440	-5.2								

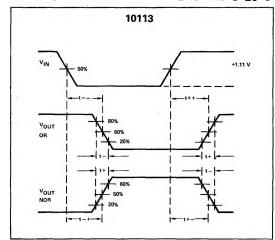
Characteristic S		Pin	10113 Test Limits								TEST VOLTAGE APPLIED TO PINS LISTED BELOW:					ĺ
		- Under Test	-30°C		+25°C		+85°C									
	Symbol		Min	Mex	Mir		Mex	Min	Мэк	Unit	VIH max	VIL min	VIHA min	VILA mex	VEE	Gnd
Power Supply Drain Current	ΙE	8	-	-	-		40	-		mAdc	-	-	-	-	8	1,16
Input Current	linH	6.7	-	-	-		265	-		μAric	6,7	-	-	-	8	1,16
		9	-	2-1	-		720	-		μAdc	9	-		-	8	1,16
	linL	•		-	0.5	П	_	- '	-	µAdc				-	8	1,16
Logic "1" Output Voltage Vo	Voн	3	-1.060	-0 890	-09	30 -	-0.810	-0.890	-0.700	Vdc	6	-	-		8	1,16
		3	-1.060	-0 890	-09	- 00	-0,810	-0 890	-0.700	Vdc	, ,	-	-	-	8	1,16
Logic "0" Output Valtage VOL	VOL	3	-1.890	-1,675	-1.89	50 -	-1 660	-1.825	-1.615	Vdc	-	-	_	-	8	1,16
	1	3	-1.890	-1,675	-1.8	50 -	-1.650	-1.825	-1,615	Vdc	6,7	-	-	-	8	1,16
Logic "1" Threshold Voltage VOH	VOHA	3	-1.080	(-0.98	30	_	-0.910		Vdc	1-1	(44)	6		8	1,16
	L	3	-1.080		-0.98	30	-	-0.910		Vdc	-	-	7	-	8	1,16
Logic "0" Threshold Voltage	VOLA	3		-1.655	_	T-	1.630		-1.595	Vdc	7	-	6	-	8	1,16
		1 3)	120	-1,665		-) -	-1,630		-1.595	Vdc	5-0	1ec		6	- 8	1.16
Switching Times [†] (60 Ω load)					Min	Тур	Max		,	Unit	+1.11 V		Pulse In	Pulse Out	-3.2 V	+2.0 \
	1++	3		ì	1	2.5			i	ns	-		6	3	8	1,16
	1+-	1 1 1		ł	ł	1	1	1		l i	7	-	-	-	1 .	1 .
	t=+	1 1 1			l	1	i			1 1	7	-		-	1 1	1 1
	t	'			l .	,				1	-	-	-	-	' '	, ,
	t+-	2,3,14.15				2.7					4,7,11,13	-	9	2,3,14,15		
	t-+	1 1		ľ	ĺ	2.7		ľ		ĺι	1-0	-	~	-	1 1	1 1
Rise Time (20% to 80%)	1+	1 1 1			l	2.5	1			1 1 -	-	_	Any Input	-		1
Fall Time (20% to 80%)	1-	1 7 1		l	l	2.5	1	I		, T	7 -0 1	-	Any Input			١ ٢

^{*}Individually test each input applying VIH or VII to input under test

SWITCHING TIME TEST CIRCUIT



PROPAGATION DELAY WAVEFORMS @ 25°C



NOTES:

- 1. Each ECL 10,000 series device has been designed to meet the DC specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a linear printed circuit board and transverse air flow greater than 500 fpm is maintained. Voltage levels will shift approximately 4 mV with an air flow of 200 linear fpm, Outputs are terminated through a 50-ohm resistor to -2.0 volts.
- 2. For AC tests, all input and output cables to the scope are equal lengths of 50-ohm coaxial cable. Wire length should be < 1/4 inch from TP_{in} to input pin and TP_{out} to output pin. A 50-ohm termination to ground is located in each scope Input, Unused outputs are connected to a 50-ohm resistor to ground.
- 3. Test procedures are shown for only one input or set of input conditions. Other inputs are tested in the same manner.
- All voltage measurements are referenced to the ground terminal. Terminals not specifically referenced are left electrically open.

^{**}Any Output †Unused outputs connected to a 50-ohm resistor to ground,